



OPA4188 0.03- $\mu\text{V}/^\circ\text{C}$ Drift, Low-Noise, Rail-to-Rail Output, 36-V, Zero-Drift Operational Amplifiers

1 Features

- Low Offset Voltage: 25 μV (Maximum)
- Zero-Drift: 0.03 $\mu\text{V}/^\circ\text{C}$
- Low Noise: 8.8 $\text{nV}/\sqrt{\text{Hz}}$
0.1-Hz to 10-Hz Noise: 0.25 μV_{PP}
- Excellent DC Precision:
PSRR: 142 dB
CMRR: 146 dB
Open-Loop Gain: 136 dB
- Gain Bandwidth: 2 MHz
- Quiescent Current: 475 μA (Maximum)
- Wide Supply Range: $\pm 2\text{ V}$ to $\pm 18\text{ V}$
- Rail-to-Rail Output:
Input Includes Negative Rail
- RFI Filtered Inputs
- *MicroSIZE* Packages

2 Applications

- Bridge Amplifiers
- Strain Gauges
- Test Equipment
- Transducer Applications
- Temperature Measurement
- Electronic Scales
- Medical Instrumentation
- Resistance Temperature Detectors
- Precision Active Filters

3 Description

The OPA4188 operational amplifier uses TI proprietary auto-zeroing techniques to provide low offset voltage (25 μV , maximum), and near zero-drift over time and temperature. These miniature, high-precision, low quiescent current amplifiers offer high input impedance and rail-to-rail output swing within 15 mV of the rails, making them ideal for industrial applications. The input common-mode range includes the negative rail. Either single or dual supplies can be used in the range of 4 V to 36 V ($\pm 2\text{ V}$ to $\pm 18\text{ V}$).

The quad version is available in 14-pin SOIC and 14-pin TSSOP packages. All versions are specified for operation from -40°C to $+125^\circ\text{C}$.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
OPA4188	SOIC (14)	8.65 mm $\times$ 3.91 mm
	TSSOP (14)	5.00 mm $\times$ 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Zero-Drift Architecture Improves Performance

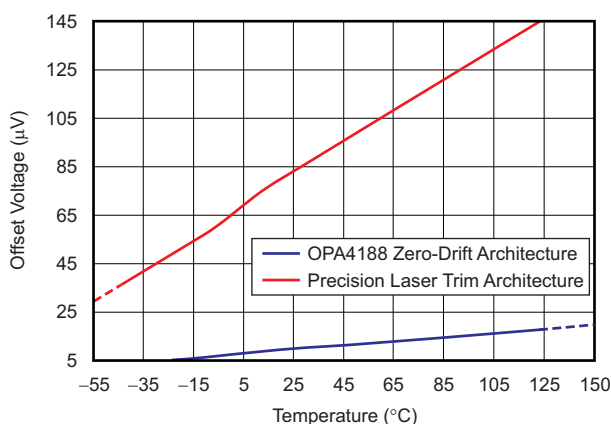


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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (April 2015) to Revision D	Page
• Changed high supply over-temperature input bias current limit in <i>High-Voltage Operation Electrical Characteristics</i> table	6
• Changed high supply noise units in <i>High-Operating Voltage Electrical Characteristics</i> table	6
• Changed high supply room-temperature quiescent current limit in <i>High-Voltage Operation Electrical Characteristics</i> table	7
• Changed high supply over-temperature quiescent current limit in <i>High-Voltage Operation Electrical Characteristics</i> table	7
• Changed low supply over-temperature input bias current limit in <i>Low-Voltage Operation Electrical Characteristics</i> table	7
• Changed low supply noise units for input voltage noise density parameter in <i>Low-Voltage Operation Electrical Characteristics</i> table	7
• Changed low supply room-temperature quiescent current limit in <i>Low-Voltage Operation Electrical Characteristics</i> table ..	8
• Changed low supply over-temperature quiescent current limit in <i>Low-Voltage Operation Electrical Characteristics</i> table ...	8

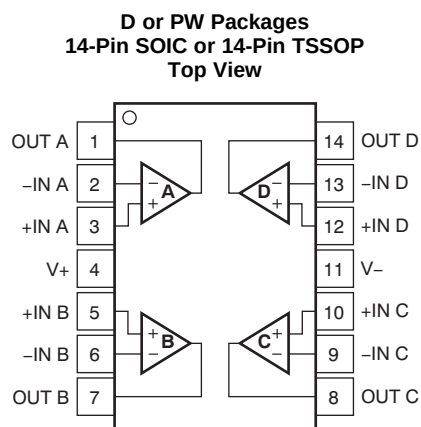
Changes from Revision A (September 2012) to Revision B	Page
• Changed maximum specification of second Input Bias Current, I_B parameter row in <i>High-Voltage Operation Electrical Characteristics</i> table	6
• Changed maximum specification of second <i>Input Bias Current</i> (I_B) parameter in <i>Low-Voltage Electrical Characteristics</i> table	7
• Changed typical specifications for <i>Input impedance (Common-mode)</i> parameter in <i>Low-Voltage Electrical Characteristics</i> table	7

Changes from Original (June 2012) to Revision A	Page
• Changed second to last <i>Applications</i> bullet	1

5 Zero-Drift Amplifier Portfolio

VERSION	PRODUCT	OFFSET VOLTAGE (μV)	OFFSET VOLTAGE DRIFT ($\mu\text{V}/^\circ\text{C}$)	BANDWIDTH (MHz)
Single	OPA188 (4 V to 36 V)	25	0.085	2
	OPA333 (5 V)	10	0.05	0.35
	OPA378 (5 V)	50	0.25	0.9
	OPA735 (12 V)	5	0.05	1.6
Dual	OPA2188 (4 V to 36 V)	25	0.085	2
	OPA2333 (5 V)	10	0.05	0.35
	OPA2378 (5 V)	50	0.25	0.9
	OPA2735 (12 V)	5	0.05	1.6
Quad	OPA4188 (4 V to 36 V)	25	0.085	2
	OPA4330 (5 V)	50	0.25	0.35

6 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NO.	NAME		
1	OUT A	O	Output channel A
2	–IN A	I	Inverting input channel A
3	+IN A	I	Noninverting input channel A
4	V+	I	Positive power supply
5	+IN B	I	Noninverting input channel B
6	–IN B	I	Inverting input channel B
7	OUT B	O	Output channel B
8	OUT C	O	Output channel C
9	–IN C	I	Inverting input channel C
10	+IN C	I	Noninverting input channel C
11	V–	I	Negative power supply
12	+IN D	I	Noninverting input channel D
13	–IN D	I	Inverting input channel D
14	OUT D	O	Output channel D

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Supply voltage		±20	40 (single supply)	V
Signal input terminals ⁽²⁾	Voltage	(V–) – 0.5	(V+) + 0.5	V
	Current		±10	mA
Output short circuit ⁽³⁾		Continuous		
Temperature	Operating, T _A	–55	150	°C
	Junction, T _J		150	°C
	Storage, T _{stg}	–65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5-V beyond the supply rails should be current-limited to 10 mA or less.
- (3) Short-circuit to ground, one amplifier per package.

7.2 ESD Ratings

		VALUE	UNIT
V _(ESD) Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±2000	V
	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	MIN	NOM	MAX	UNIT
Power supply voltage, (V+)–(V–)	4 (±2)		36 (±18)	V
Ambient temperature, T _A	–40		125	°C

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾		OPA4188		UNIT
		D (SOIC)	PW (TSSOP)	
		14 PINS	14 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	93.2	106.9	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	51.8	24.4	°C/W
R _{θJB}	Junction-to-board thermal resistance	49.4	59.3	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	13.5	0.6	°C/W
Ψ _{JB}	Junction-to-board characterization parameter	42.2	54.3	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	N/A	°C/W

- (1) For more information about traditional and new thermal metrics, see [Semiconductor and IC Package Thermal Metrics](#) (SPRA953).

7.5 Electrical Characteristics: High-Voltage Operation, $V_S = \pm 4\text{ V}$ to $\pm 18\text{ V}$ ($V_S = 8\text{ V}$ to 36 V)

at $T_A = 25^\circ\text{C}$, $R_L = 10\text{ k}\Omega$ connected to $V_S / 2$, and $V_{\text{COM}} = V_{\text{OUT}} = V_S / 2$, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET VOLTAGE						
V _{OS}	Input offset voltage	T _A = 25°C		6	25	μV
dV _{OS} /dT		T _A = −40°C to 125°C		0.03	0.085	μV/°C
PSRR	Power-supply rejection ratio	V _S = 4 V to 36 V, V _{CM} = V _S / 2		0.075	0.3	μV/V
		V _S = 4 V to 36 V, V _{CM} = V _S / 2, T _A = −40°C to 125°C			0.3	μV/V
Long-term stability				4 ⁽¹⁾		μV
Channel separation, DC				1		μV/V
INPUT BIAS CURRENT						
I _B	Input bias current	V _{CM} = V _S / 2		±160	±1400	pA
		T _A = −40°C to 125°C			±18	nA
I _{OS}	Input offset current			±320	±2800	pA
		T _A = −40°C to 125°C			±6	nA
NOISE						
e _n	Input voltage noise	f = 0.1 Hz to 10 Hz		0.25		μV _{PP}
e _n	Input voltage noise density	f = 1 kHz		8.8		nV/√Hz
i _n	Input current noise density	f = 1 kHz		7		fA/√Hz
INPUT VOLTAGE RANGE						
V _{CM}	Common-mode voltage range	T _A = −40°C to 125°C	V−		(V+) − 1.5	V
CMRR	Common-mode rejection ratio	(V−) < V _{CM} < (V+) − 1.5 V	120	134		dB
		(V−) + 0.5 V < V _{CM} < (V+) − 1.5 V, V _S = ±18 V	130	146		dB
		(V−) + 0.5 V < V _{CM} < (V+) − 1.5 V, V _S = ±18 V, T _A = −40°C to 125°C	120	126		dB
INPUT IMPEDANCE						
Input impedance		Differential		100 6		MΩ pF
		Common-mode		6 9.5		10 ¹² Ω pF
OPEN-LOOP GAIN						
A _{OL}	Open-loop voltage gain	(V−) + 500 mV < V _O < (V+) − 500 mV, R _L = 10 kΩ	130	136		dB
		(V−) + 500 mV < V _O < (V+) − 500 mV, R _L = 10 kΩ, T _A = −40°C to 125°C	118	126		dB
FREQUENCY RESPONSE						
GBW	Gain-bandwidth product			2		MHz
SR	Slew rate	G = 1		0.8		V/μs
t _s	Settling time	0.1%	V _S = ±18 V, G = 1, 10-V step		20	μs
		0.01%	V _S = ±18 V, G = 1, 10-V step		27	μs
Overload recovery time		V _{IN} × G = V _S		1		μs
THD+N	Total harmonic distortion + noise	1 kHz, G = 1, V _{OUT} = 1 V _{RMS}		0.0001%		

(1) 1000-hour life test at $+125^\circ\text{C}$ demonstrated randomly distributed variation in the range of measurement limits—approximately $4\text{ }\mu\text{V}$.

Electrical Characteristics: High-Voltage Operation, $V_S = \pm 4\text{ V}$ to $\pm 18\text{ V}$ ($V_S = 8\text{ V}$ to 36 V) (continued)

at $T_A = 25^\circ\text{C}$, $R_L = 10\text{ k}\Omega$ connected to $V_S / 2$, and $V_{\text{COM}} = V_{\text{OUT}} = V_S / 2$, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT						
Voltage output swing from rail		No load		6	15	mV
		R _L = 10 kΩ		220	250	mV
		R _L = 10 kΩ, T _A = −40°C to 125°C		310	350	mV
I _{SC}	Short circuit current			±18		mA
R _O	Open-loop output resistance	f = 1 MHz, I _O = 0		120		Ω
C _{LOAD}	Capacitive load drive			1		nF
POWER SUPPLY						
V _S	Operating voltage range		4 to 36 (±2 to ±18)			V
I _Q	Quiescent current (per amplifier)	V _S = ±4 V to V _S = ±18 V		415	500	μA
		I _O = 0 mA, T _A = −40°C to 125°C			570	μA
TEMPERATURE RANGE						
Temperature range	Specified		−40		125	°C
	Operating		−55		150	°C
	Storage		−65		150	°C

7.6 Electrical Characteristics: Low-Voltage Operation, $V_S = \pm 2\text{ V}$ to $< \pm 4\text{ V}$ ($V_S = +4\text{ V}$ to $< +8\text{ V}$)

at $T_A = 25^\circ\text{C}$, $R_L = 10\text{ k}\Omega$ connected to $V_S / 2$, and $V_{\text{COM}} = V_{\text{OUT}} = V_S / 2$, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET VOLTAGE						
V _{OS}	Input offset voltage	T _A = 25°C		6	25	μV
dV _{OS} /dT		T _A = −40°C to 125°C		0.03	0.085	μV/°C
PSRR	Power-supply rejection ratio	V _S = 4 V to 36 V, V _{CM} = V _S / 2		0.075	0.3	μV/V
		V _S = 4 V to 36 V, V _{CM} = V _S / 2, T _A = −40°C to 125°C			0.3	μV/V
Long-term stability				4 ⁽¹⁾		μV
Channel separation, DC				1		μV/V
INPUT BIAS CURRENT						
I _B	Input bias current	V _{CM} = V _S / 2		±160	±1400	pA
		T _A = −40°C to 125°C			±18	nA
I _{OS}	Input offset current			±320	±2800	pA
		T _A = −40°C to 125°C			±6	nA
NOISE						
e _n	Input voltage noise	f = 0.1 Hz to 10 Hz		0.25		μV _{PP}
e _n	Input voltage noise density	f = 1 kHz		8.8		nV/√Hz
i _n	Input current noise density	f = 1 kHz		7		fA/√Hz
INPUT VOLTAGE RANGE						
V _{CM}	Common-mode voltage range		V−		(V+) − 1.5	V
CMRR	Common-mode rejection ratio	(V−) < V _{CM} < (V+) − 1.5 V	106	114		dB
		(V−) + 0.5 V < V _{CM} < (V+) − 1.5 V, V _S = ±2 V	114	120		dB
		(V−) + 0.5 V < V _{CM} < (V+) − 1.5 V, V _S = ±2 V, T _A = −40°C to 125°C	108	120		dB
INPUT IMPEDANCE						
Input impedance	Differential			100 6		MΩ pF
	Common-mode			6 9.5		10 ¹² Ω pF

(1) 1000-hour life test at $+125^\circ\text{C}$ demonstrated randomly distributed variation in the range of measurement limits—approximately $4\text{ }\mu\text{V}$.

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Electrical Characteristics: Low-Voltage Operation, $V_S = \pm 2\text{ V}$ to $< \pm 4\text{ V}$ ($V_S = +4\text{ V}$ to $< +8\text{ V}$) (continued)

at $T_A = 25^\circ\text{C}$, $R_L = 10\text{ k}\Omega$ connected to $V_S / 2$, and $V_{\text{COM}} = V_{\text{OUT}} = V_S / 2$, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OPEN-LOOP GAIN						
A _{OL}	Open-loop voltage gain	(V ₋) + 500 mV < V _O < (V ₊) – 500 mV, R _L = 10 kΩ	120	130		dB
		(V ₋) + 500 mV < V _O < (V ₊) – 500 mV, R _L = 10 kΩ, T _A = –40°C to 125°C	110	120		dB
FREQUENCY RESPONSE						
GBW	Gain-bandwidth product			2		MHz
SR	Slew rate	G = 1		0.8		V/μs
	Overload recovery time	V _{IN} × G = V _S		1		μs
THD+N	Total harmonic distortion + noise	1 kHz, G = 1, V _{OUT} = 1 V _{RMS}		0.0001%		
OUTPUT						
	Voltage output swing from rail	No load		6	15	mV
		R _L = 10 kΩ		220	250	mV
		R _L = 10 kΩ, T _A = –40°C to 125°C		310	350	mV
I _{SC}	Short circuit current			±18		mA
R _O	Open-loop output resistance	f = 1 MHz, I _O = 0		120		Ω
C _{LOAD}	Capacitive load drive			1		nF
POWER SUPPLY						
V _S	Operating voltage range		4 to 36 (±2 to ±18)			V
I _Q	Quiescent current (per amplifier)	V _S = ±2 V to V _S = ±4 V		385	465	μA
		I _O = 0 mA, T _A = –40°C to 125°C			540	μA
TEMPERATURE RANGE						
Temperature range	Specified		–40		125	°C
	Operating		–40		125	°C
	Storage		–65		150	°C

7.7 Typical Characteristics

Table 1. Characteristic Performance Measurements

DESCRIPTION	FIGURE
Offset Voltage Production Distribution	Figure 1
Offset Voltage Drift Distribution	Figure 2
Offset Voltage vs Temperature	Figure 3
Offset Voltage vs Common-Mode Voltage	Figure 4, Figure 5
Offset Voltage vs Power Supply	Figure 6
I_B and I_{OS} vs Common-Mode Voltage	Figure 7
Input Bias Current vs Temperature	Figure 8
Output Voltage Swing vs Output Current (Maximum Supply)	Figure 9
CMRR and PSRR vs Frequency (Referred-to-Input)	Figure 10
CMRR vs Temperature	Figure 11, Figure 12
PSRR vs Temperature	Figure 13
0.1-Hz to 10-Hz Noise	Figure 14
Input Voltage Noise Spectral Density vs Frequency	Figure 15
THD+N Ratio vs Frequency	Figure 16
THD+N vs Output Amplitude	Figure 17
Quiescent Current vs Supply Voltage	Figure 18
Quiescent Current vs Temperature	Figure 19
Open-Loop Gain and Phase vs Frequency	Figure 20
Closed-Loop Gain vs Frequency	Figure 21
Open-Loop Gain vs Temperature	Figure 22
Open-Loop Output Impedance vs Frequency	Figure 23
Small-Signal Overshoot vs Capacitive Load (100-mV Output Step)	Figure 24, Figure 25
No Phase Reversal	Figure 26
Positive Overload Recovery	Figure 27
Negative Overload Recovery	Figure 28
Small-Signal Step Response (100 mV)	Figure 29, Figure 30
Large-Signal Step Response	Figure 31, Figure 32
Large-Signal Settling Time (10-V Positive Step)	Figure 33
Large-Signal Settling Time (10-V Negative Step)	Figure 34
Short Circuit Current vs Temperature	Figure 35
Maximum Output Voltage vs Frequency	Figure 36
Channel Separation vs Frequency	Figure 37
EMIRR IN+ vs Frequency	Figure 38

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$V_S = \pm 18\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$, unless otherwise noted.

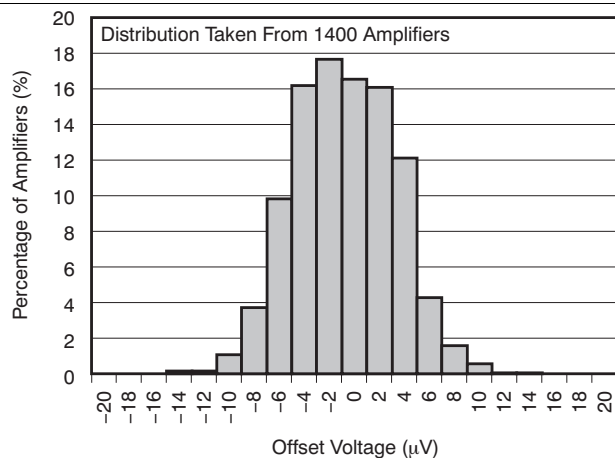


Figure 1. Offset Voltage Production Distribution

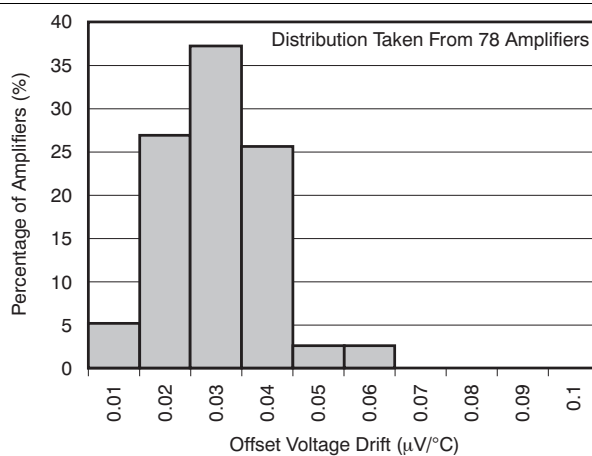


Figure 2. Offset Voltage Drift Distribution

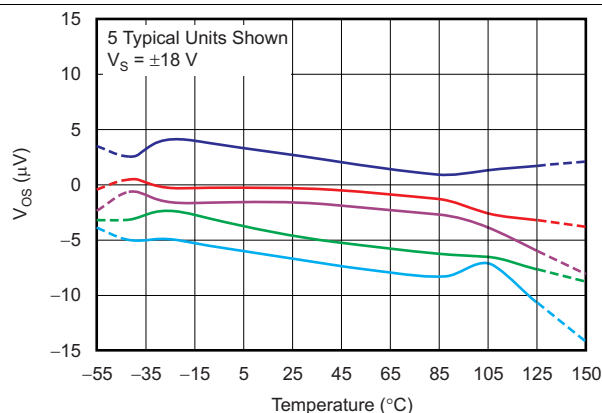


Figure 3. Offset Voltage vs Temperature

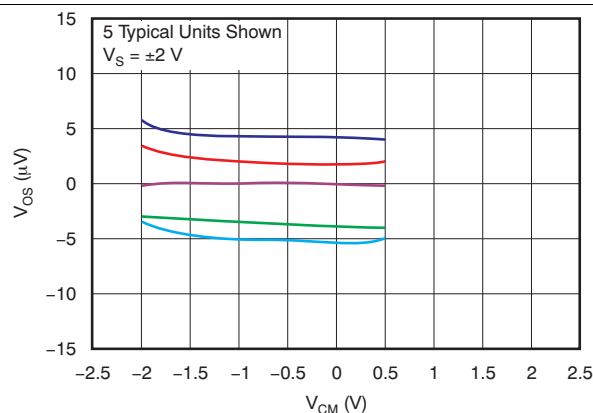


Figure 4. Offset Voltage vs Common-Mode Voltage

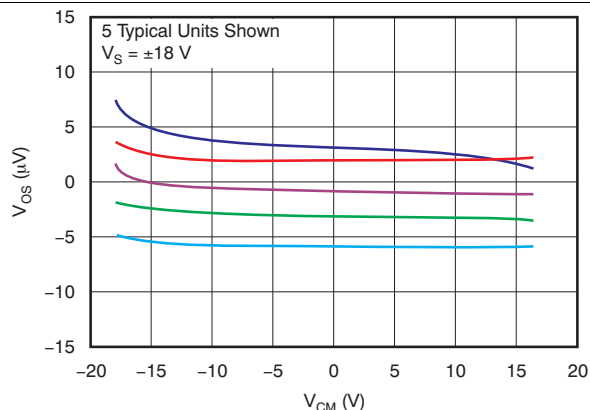


Figure 5. Offset Voltage vs Common-Mode Voltage

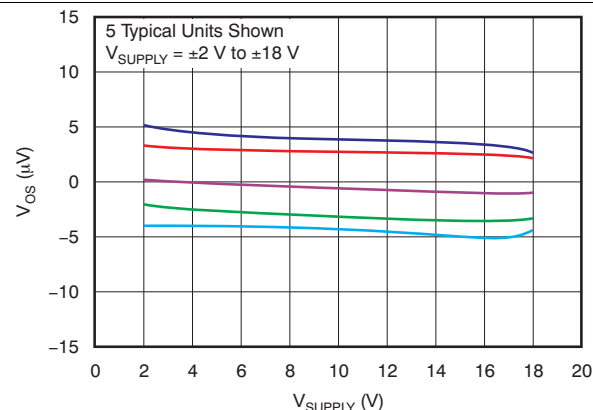


Figure 6. Offset Voltage vs Power Supply

$V_S = \pm 18\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$, unless otherwise noted.

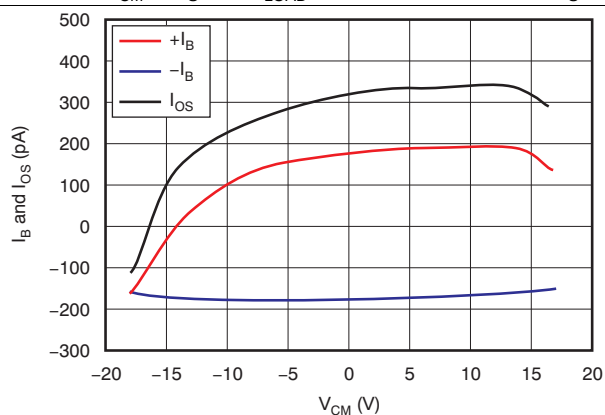


Figure 7. I_B and I_{OS} vs Common-Mode Voltage

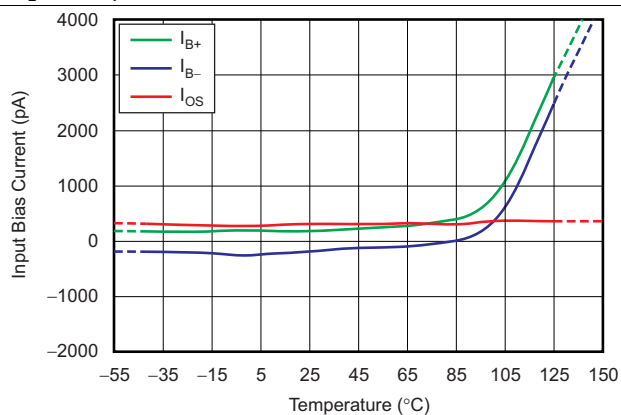


Figure 8. Input Bias Current vs Temperature

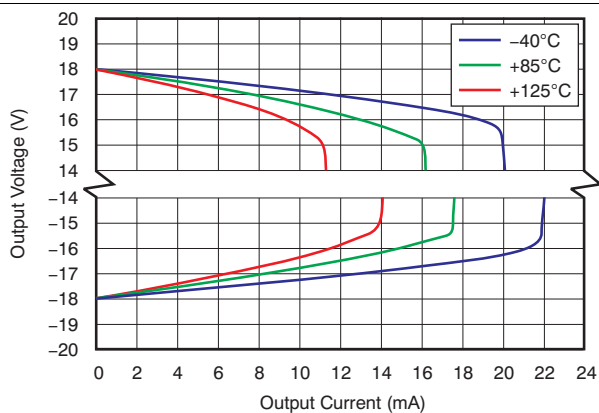


Figure 9. Output Voltage Swing vs Output Current (Maximum Supply)

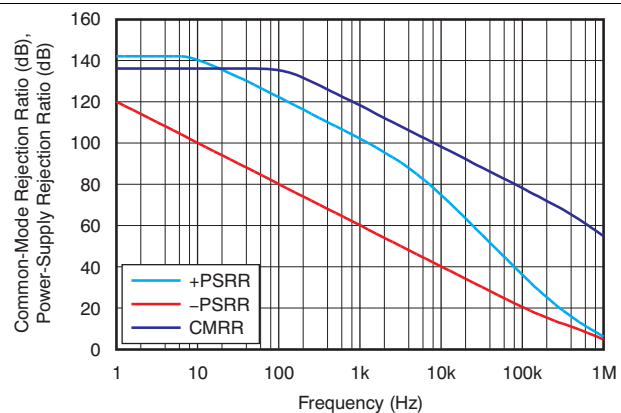


Figure 10. CMRR and PSRR vs Frequency (Referred-to-Input)

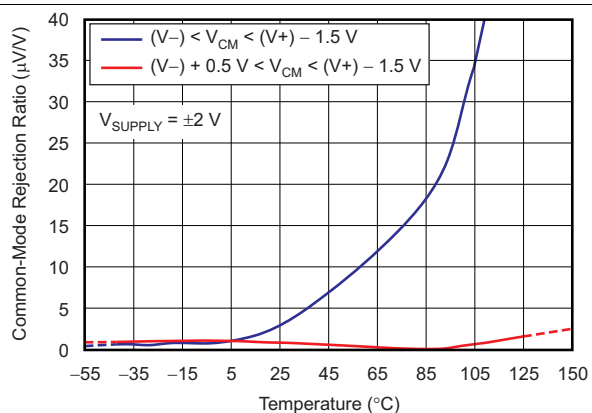


Figure 11. CMRR vs Temperature

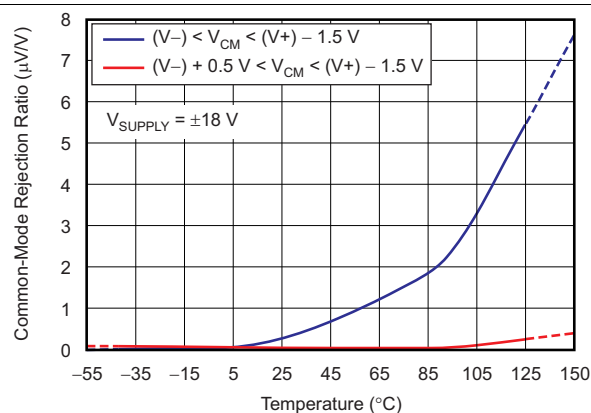
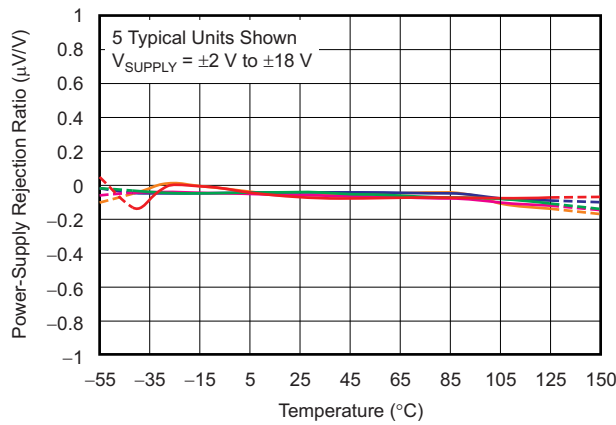
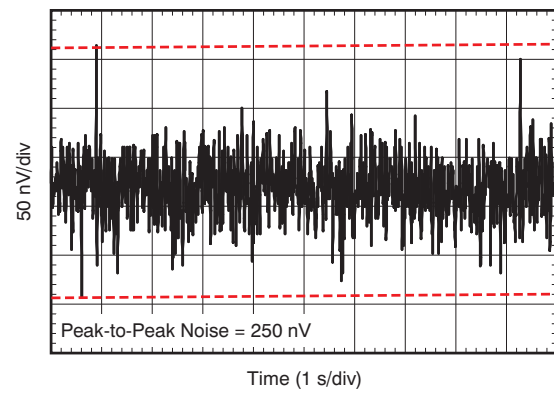
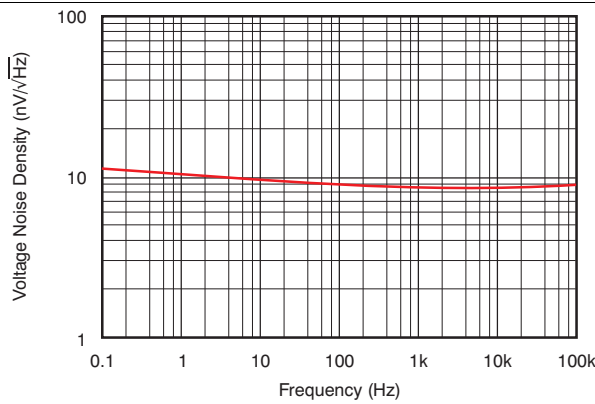
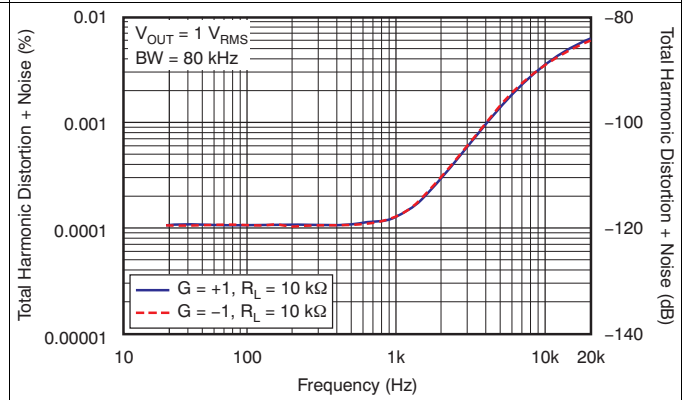
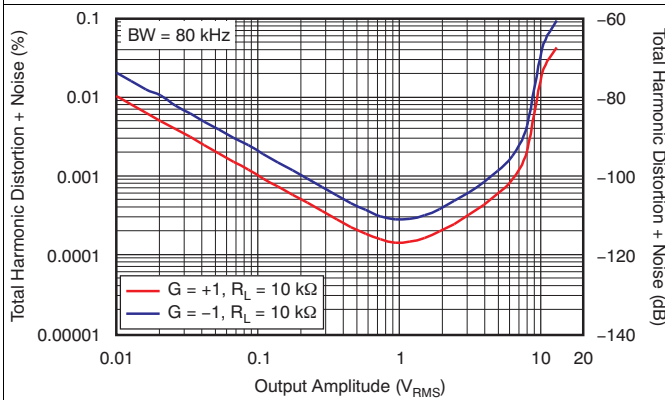
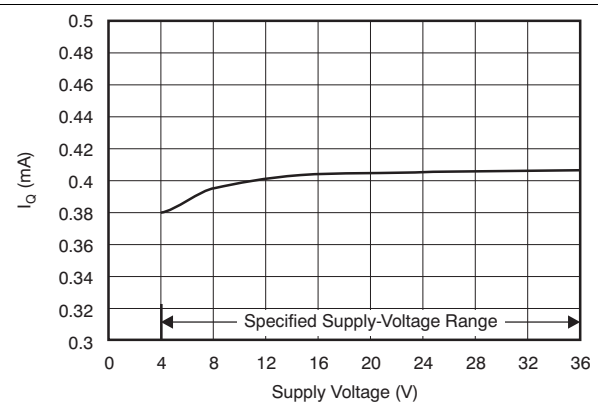


Figure 12. CMRR vs Temperature

$V_S = \pm 18\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$, unless otherwise noted.


Figure 13. PSRR vs Temperature

Figure 14. 0.1-Hz to 10-Hz Noise

Figure 15. Input Voltage Noise Spectral Density vs Frequency

Figure 16. THD+N Ratio vs Frequency

Figure 17. THD+N vs Output Amplitude

Figure 18. Quiescent Current vs Supply Voltage

$V_S = \pm 18\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$, unless otherwise noted.

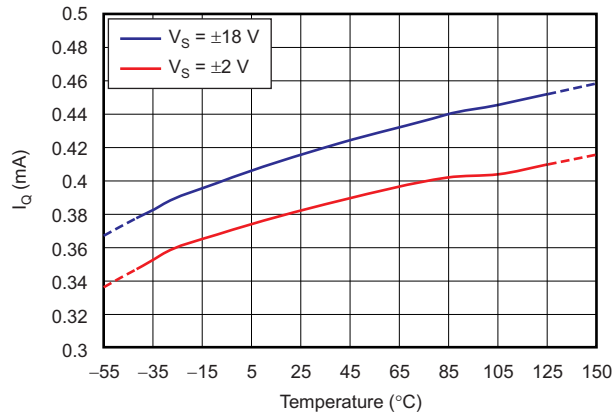


Figure 19. Quiescent Current vs Temperature

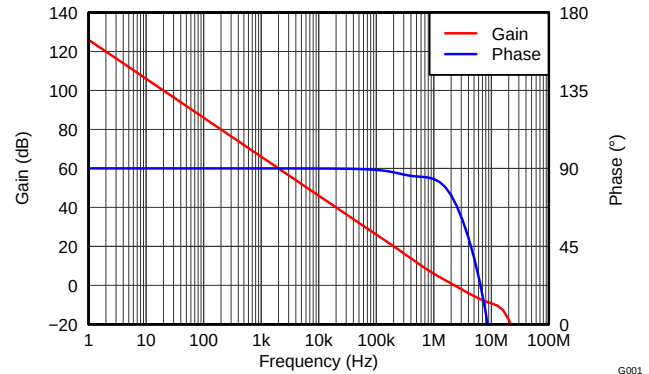


Figure 20. Open-Loop Gain and Phase vs Frequency

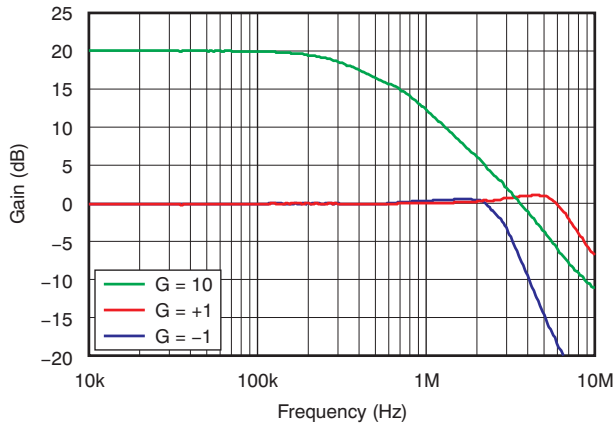


Figure 21. Closed-Loop Gain vs Frequency

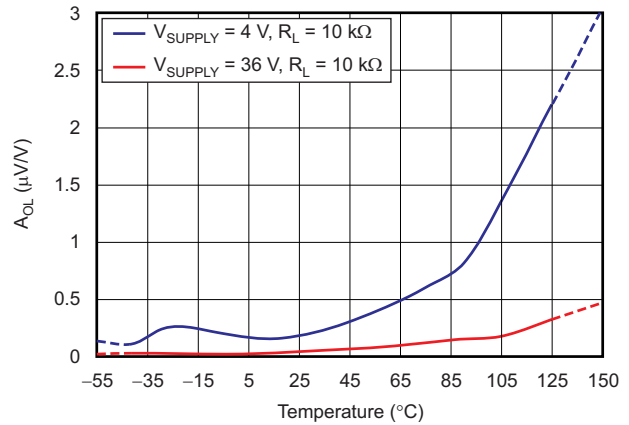


Figure 22. Open-Loop Gain vs Temperature

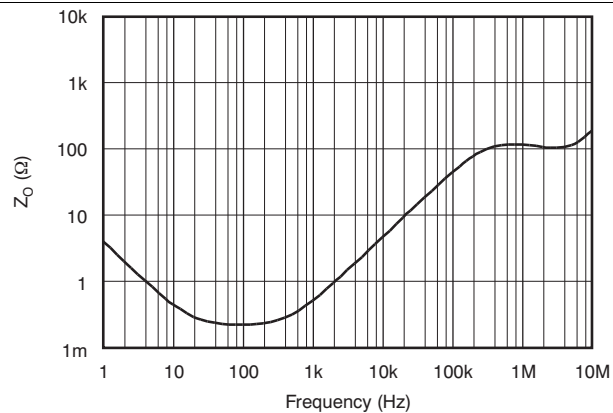


Figure 23. Open-Loop Output Impedance vs Frequency

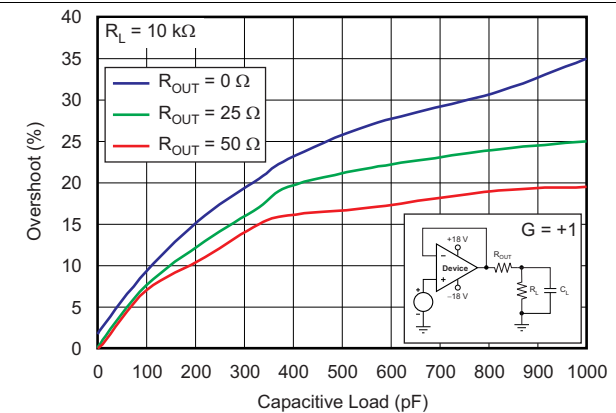
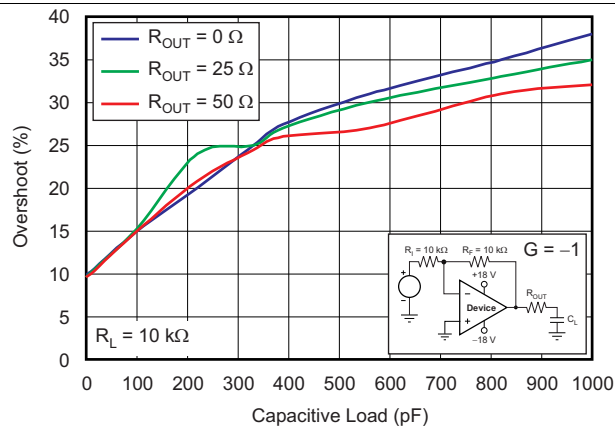
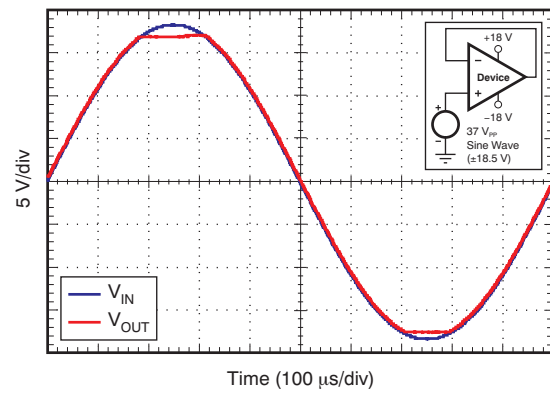
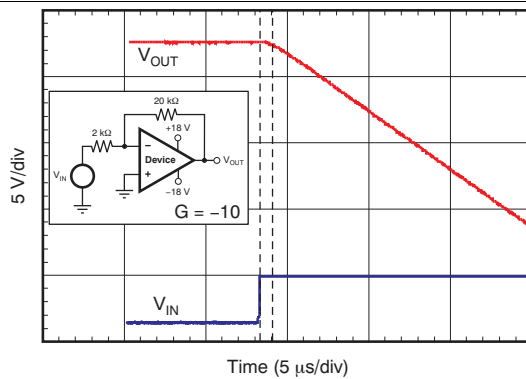
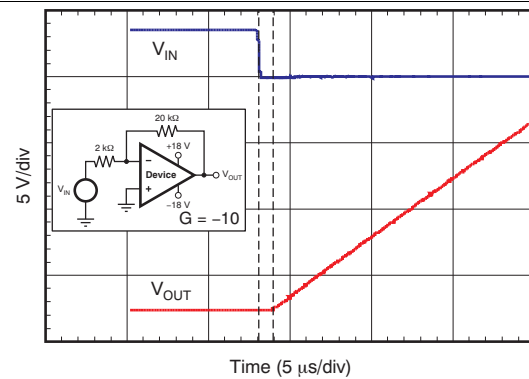
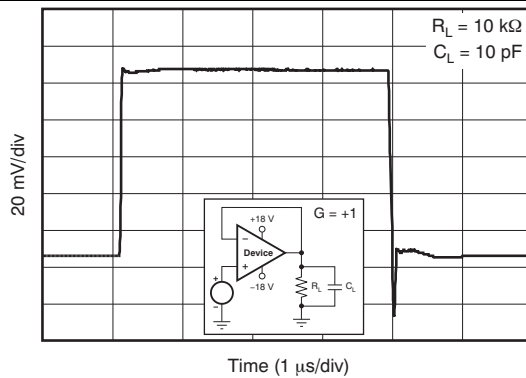
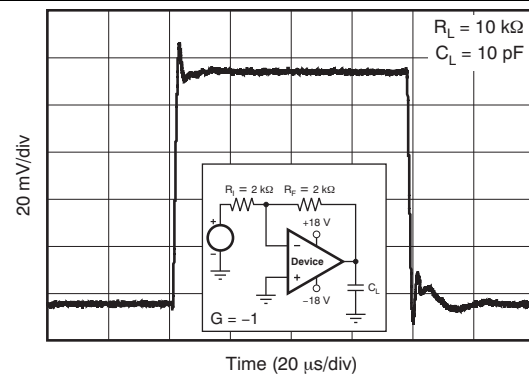


Figure 24. Small-Signal Overshoot vs Capacitive Load (100-mV Output Step)

OPA4188

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 $V_S = \pm 18\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$, unless otherwise noted.

Figure 25. Small-Signal Overshoot vs Capacitive Load (100-mV Output Step)

Figure 26. No Phase Reversal

Figure 27. Positive Overload Recovery

Figure 28. Negative Overload Recovery

Figure 29. Small-Signal Step Response (100 mV)

Figure 30. Small-Signal Step Response (100 mV)

$V_S = \pm 18\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$, unless otherwise noted.

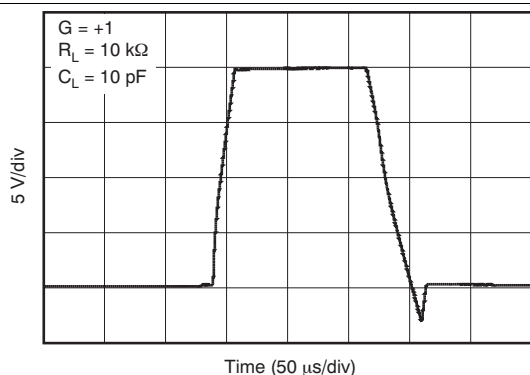


Figure 31. Large-Signal Step Response

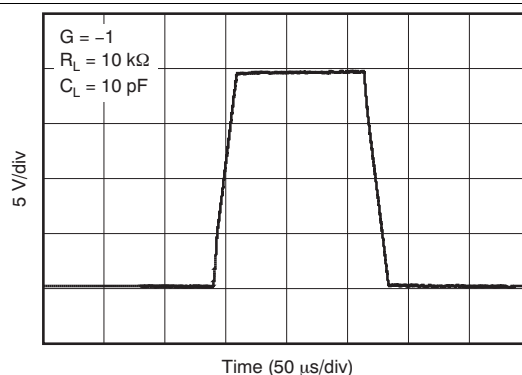


Figure 32. Large-Signal Step Response

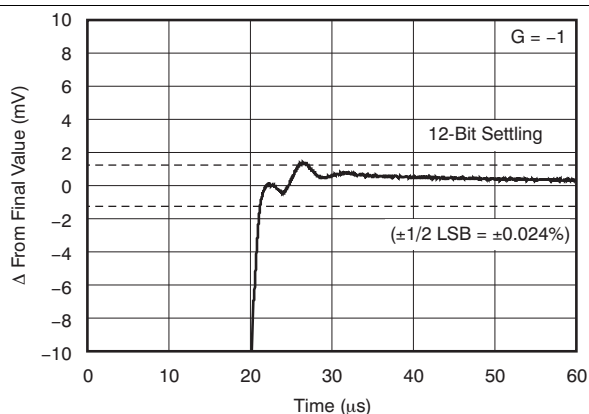


Figure 33. Large-Signal Settling Time (10-V Positive Step)

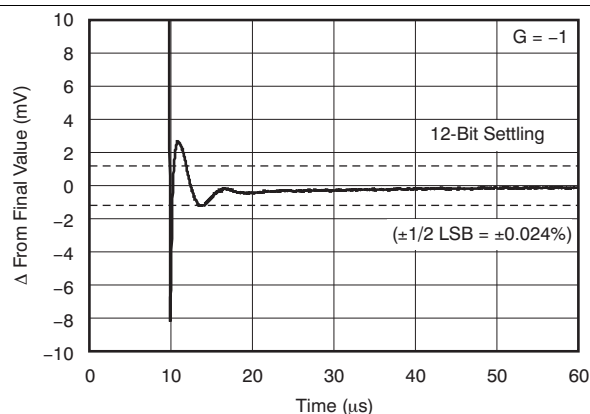


Figure 34. Large-Signal Settling Time (10-V Negative Step)

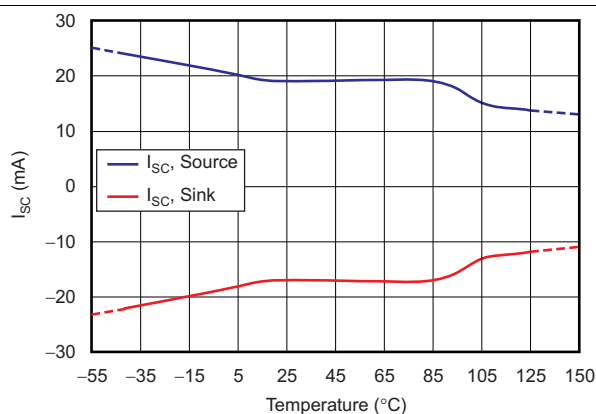


Figure 35. Short Circuit Current vs Temperature

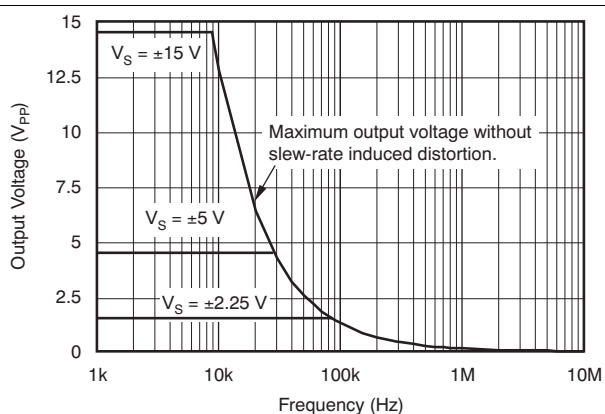


Figure 36. Maximum Output Voltage vs Frequency

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$V_S = \pm 18\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$, unless otherwise noted.

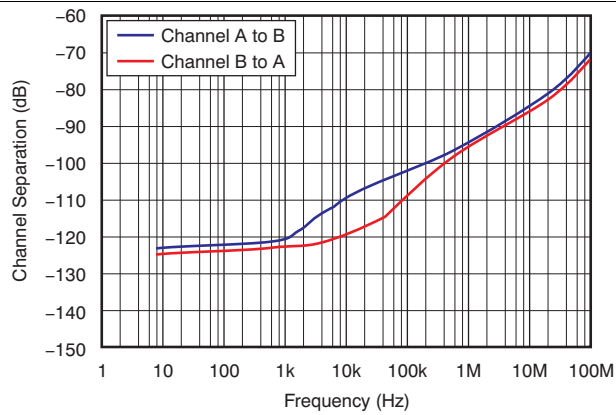


Figure 37. Channel Separation vs Frequency

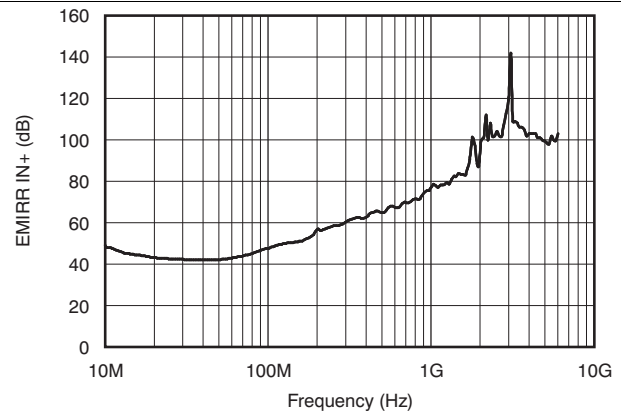
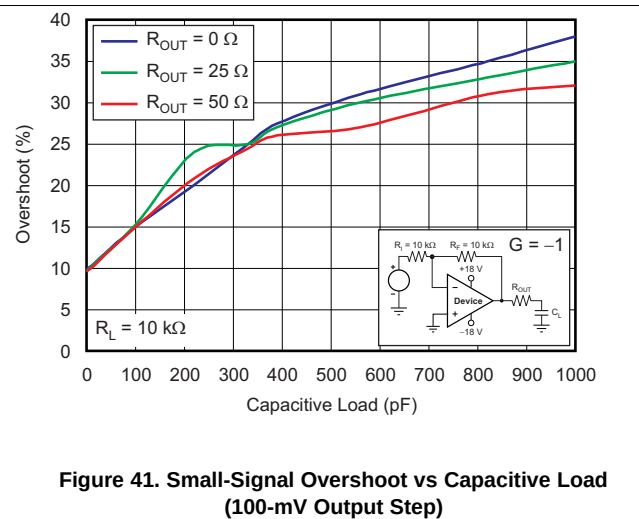
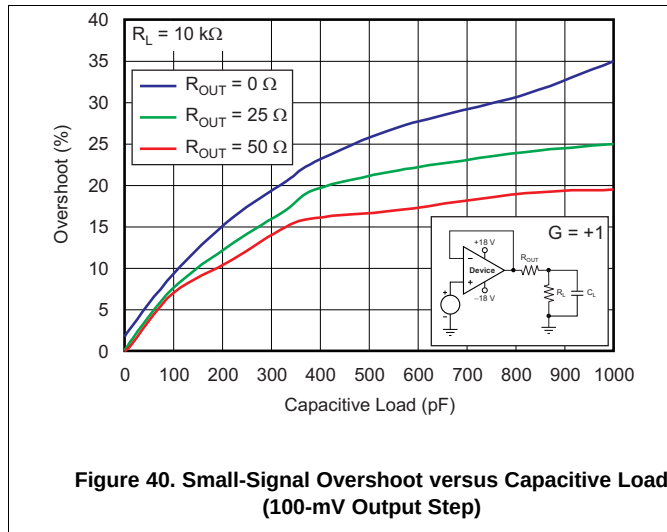


Figure 38. EMIRR IN+ vs Frequency

Feature Description (continued)

8.3.2 Capacitive Load and Stability

The OPA4188 dynamic characteristics have been optimized for a range of common operating conditions. The combination of low closed-loop gain and high capacitive loads decreases the amplifier phase margin and can lead to gain peaking or oscillations. As a result, heavier capacitive loads must be isolated from the output. The simplest way to achieve this isolation is to add a small resistor (for example, R_{OUT} equal to $50\ \Omega$) in series with the output. Figure 40 and Figure 41 illustrate graphs of small-signal overshoot versus capacitive load for several values of R_{OUT} . For details of analysis techniques and application circuits, see [Feedback Plots Define Op Amp AC Performance](#), available for download from [www.ti.com](#).



8.3.3 Electrical Overstress

Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress. These questions tend to focus on the device inputs, but may involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits to protect them from accidental ESD events both before and during product assembly.

These ESD protection diodes also provide in-circuit, input overdrive protection, as long as the current is limited to 10 mA as stated in the [Absolute Maximum Ratings](#). Figure 42 shows how a series input resistor may be added to the driven input to limit the input current. The added resistor contributes thermal noise at the amplifier input and its value should be kept to a minimum in noise-sensitive applications.

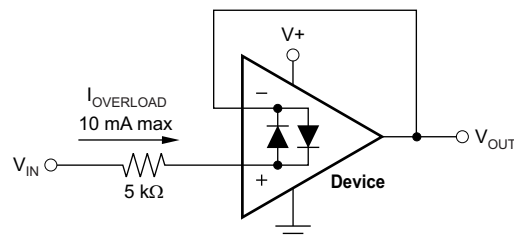


Figure 42. Input Current Protection

An ESD event produces a short-duration, high-voltage pulse that is transformed into a short-duration, high-current pulse as it discharges through a semiconductor device. The ESD protection circuits are designed to provide a current path around the operational amplifier core to prevent it from being damaged. The energy absorbed by the protection circuitry is then dissipated as heat.

Feature Description (continued)

When the operational amplifier connects into a circuit, the ESD protection components are intended to remain inactive and not become involved in the application circuit operation. However, circumstances may arise where an applied voltage exceeds the operating voltage range of a given pin. Should this condition occur, there is a risk that some of the internal ESD protection circuits may be biased on, and conduct current. Any such current flow occurs through ESD cells and rarely involves the absorption device.

If there is an uncertainty about the ability of the supply to absorb this current, external Zener diodes may be added to the supply pins. The Zener voltage must be selected such that the diode does not turn on during normal operation. However, its Zener voltage should be low enough so that the Zener diode conducts if the supply pin begins to rise above the safe operating supply voltage level.

8.3.4 EMI Rejection

The OPA4188 device uses integrated electromagnetic interference (EMI) filtering to reduce the effects of EMI interference from sources such as wireless communications and densely-populated boards with a mix of analog signal chain and digital components. EMI immunity can be improved with circuit design techniques; the OPA4188 benefits from these design improvements. Texas Instruments has developed the ability to accurately measure and quantify the immunity of an operational amplifier over a broad frequency spectrum extending from 10 MHz to 6 GHz. [Figure 43](#) shows the results of this testing on the OPA4188 device. Detailed information can also be found in [EMI Rejection Ratio of Operational Amplifiers](#) available for download from www.ti.com.

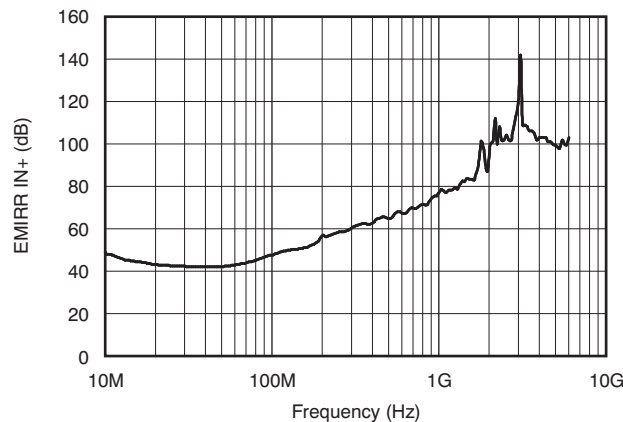


Figure 43. EMIRR Testing

8.4 Device Functional Modes

The OPA4188 device has a single functional mode that is operational when the power-supply voltage is greater than 4 V (± 2 V). The maximum power supply voltage for the OPA4188 is 36 V (± 18 V).

9 Applications and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The OPA4188 operational amplifier combines precision offset and drift with excellent overall performance, making it ideal for many precision applications. The precision offset drift of only 0.085 μV per degree Celsius provides stability over the entire temperature range. In addition, the device offers excellent overall performance with high CMRR, PSRR, and A_{OL} . As with all amplifiers, applications with noisy or high-impedance power supplies require decoupling capacitors close to the device pins. In most cases, 0.1- μF capacitors are adequate.

The application examples of [Figure 46](#) and [Figure 47](#) highlight only a few of the circuits where the OPA4188 device can be used.

9.1.1 Operating Characteristics

The OPA4188 device is specified for operation from 4 V to 36 V (± 2 V to ± 18 V). Many of the specifications apply from -40°C to 125°C . Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the [Typical Characteristics](#).

9.2 Typical Applications

9.2.1 Second Order Low Pass Filter

Low pass filters are commonly employed in signal processing applications to reduce noise and prevent aliasing. The OPA4188 device is ideally suited to construct a high precision active filter. [Figure 44](#) illustrates a second order low pass filter commonly encountered in signal processing applications.

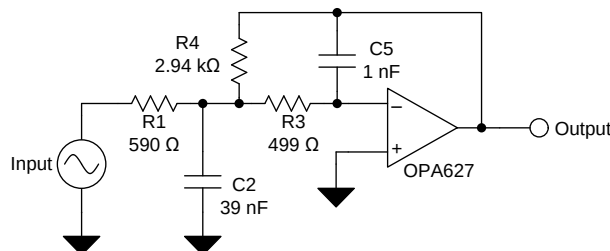


Figure 44. 25-kHz Low Pass Filter

9.2.1.1 Design Requirements

Use the following parameters for this design example:

- Gain = 5 V/V (inverting gain)
- Low-pass cutoff frequency = 25 kHz
- Second order Chebyshev filter response with 3-dB gain peaking in the passband

9.2.1.2 Detailed Design Procedure

The infinite-gain multiple-feedback circuit for a low-pass network function is shown in [Figure 44](#). Use [Equation 1](#) to calculate the voltage transfer function.

$$\frac{\text{Output}}{\text{Input}}(s) = \frac{-1/R_1 R_3 C_2 C_5}{s^2 + (s/C_2)(1/R_1 + 1/R_3 + 1/R_4) + 1/R_3 R_4 C_2 C_5} \quad (1)$$

Typical Applications (continued)

This circuit produces a signal inversion. For this circuit, use [Equation 2](#) to calculate the gain at DC and the low-pass cutoff frequency.

$$\text{Gain} = \frac{R_4}{R_1}$$

$$f_c = \frac{1}{2\pi} \sqrt{\frac{1}{R_3 R_4 C_2 C_5}} \quad (2)$$

Software tools are readily available to simplify filter design. [WEBENCH® Filter Designer](#) is a simple, powerful, and easy-to-use active filter design program. The WEBENCH Filter Designer lets you create optimized filter designs using a selection of TI operational amplifiers and passive components from TI's vendor partners. Available as a web based tool from the [WEBENCH® Design Center](#), WEBENCH® Filter Designer allows you to design, optimize, and simulate complete multi-stage active filter solutions within minutes.

9.2.1.3 Application Curve

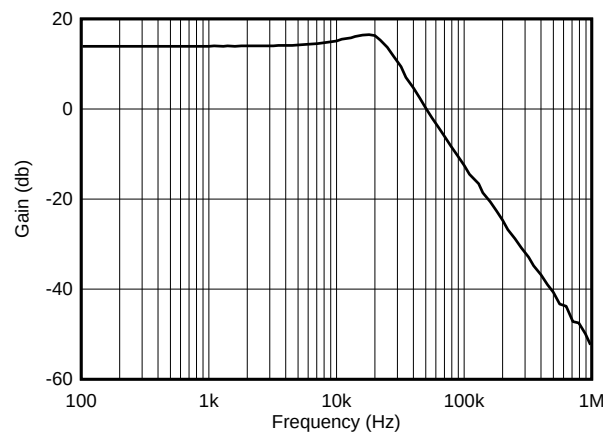


Figure 45. Gain (dB) vs Frequency (Hz)

9.2.2 Discrete INA + Attenuation for ADC With a 3.3-V Supply

[Figure 46](#) illustrates a circuit with high input impedance that can accommodate ± 2 V differential input signals. The output, V_{OUT} , is scaled into the full scale input range of a 3.3 V analog to digital converter. Input common mode voltages as high as ± 10 V can be present with no signal clipping. Input stage gain is determined by resistors R_5 , R_6 and R_7 according to [Equation 3](#).

$$\text{Gain} = 0.2 \times \frac{(R_5 + R_7)}{R_6} \quad (3)$$

Typical Applications (continued)

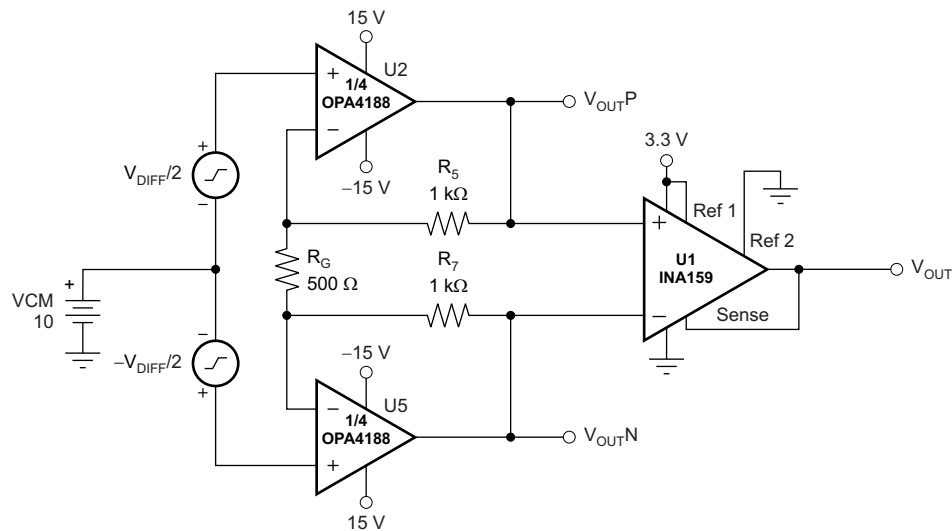
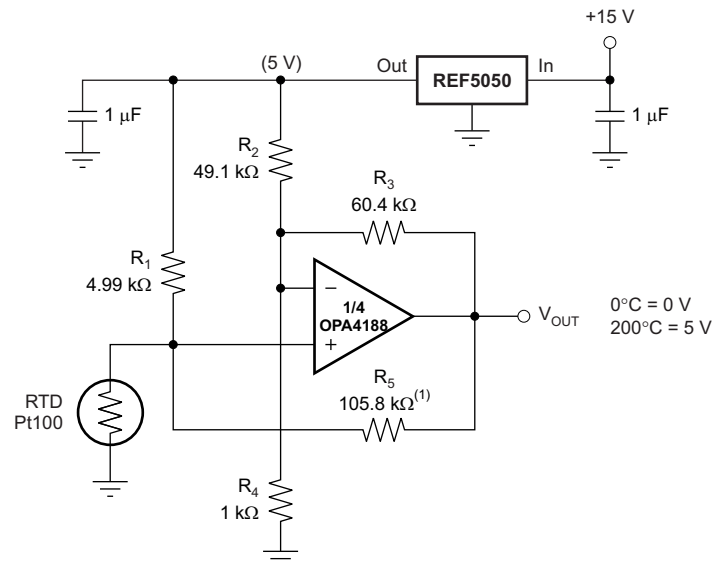


Figure 46. Discrete INA + Attenuation for ADC With a 3.3-V Supply Circuit

9.2.3 RTD Amplifier With Linearization

The OPA4188 device with ultra-low input offset voltage and ultra-low input offset voltage drift is ideally suited for RTD signal conditioning. Figure 47 illustrates a Pt100 RTD with excitation provided by a voltage reference and resistor R_1 . Linearization is provided by R_5 . Gain is determined by R_2 , R_3 and R_4 . The circuit is configured such that the output, V_{OUT} , ranges from 0 V to 5 V over the temperature range from 0°C to 200°C. The OPA4188 requires split power supplies (± 5.35 V to ± 15 V) for proper operation in this configuration.



(1) R_5 provides positive-varying excitation to linearize output.

Figure 47. RTD Amplifier With Linearization Circuit

10 Power Supply Recommendations

The OPA4188 device is specified for operation from 4 V to 36 V (± 2 V to ± 18 V); many specifications apply from -40°C to 125°C and -55°C to 125°C . Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the [Typical Characteristics](#). Low-loss, 0.1- μF bypass capacitors should be connected between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from $V+$ to ground is applicable to single-supply applications.

11 Layout

11.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and operational amplifier itself. Bypass capacitors are used to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
 - Connect low-ESR, 0.1- μF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from $V+$ to ground is applicable for single-supply applications.
 - The OPA6x7 is capable of high-output current (in excess of 45 mA). Applications with low impedance loads or capacitive loads with fast transient signals demand large currents from the power supplies. Larger bypass capacitors such as 1- μF solid tantalum capacitors may improve dynamic performance in these applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most-effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Make sure to physically separate digital and analog grounds paying attention to the flow of the ground current. For more detailed information, see [Circuit Board Layout Techniques](#).
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better as opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible. As shown in [Figure 48](#), keeping RF and RG close to the inverting input minimizes parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.
- The case (TO-99 metal package only) is internally connected to the negative power supply, as with most common operational amplifiers.
- Pin 8 of the plastic PDIP, SOIC, and TO-99 packages has no internal connection.
- Cleaning the PCB following board assembly is recommended for best performance.
- Any precision integrated circuit may experience performance shifts due to moisture ingress into the plastic package. Following any aqueous PCB cleaning process, baking the PCB assembly is recommended to remove moisture introduced into the device packaging during the cleaning process. A low temperature, post cleaning bake at 85°C for 30 minutes is sufficient for most circumstances.

11.2 Layout Example

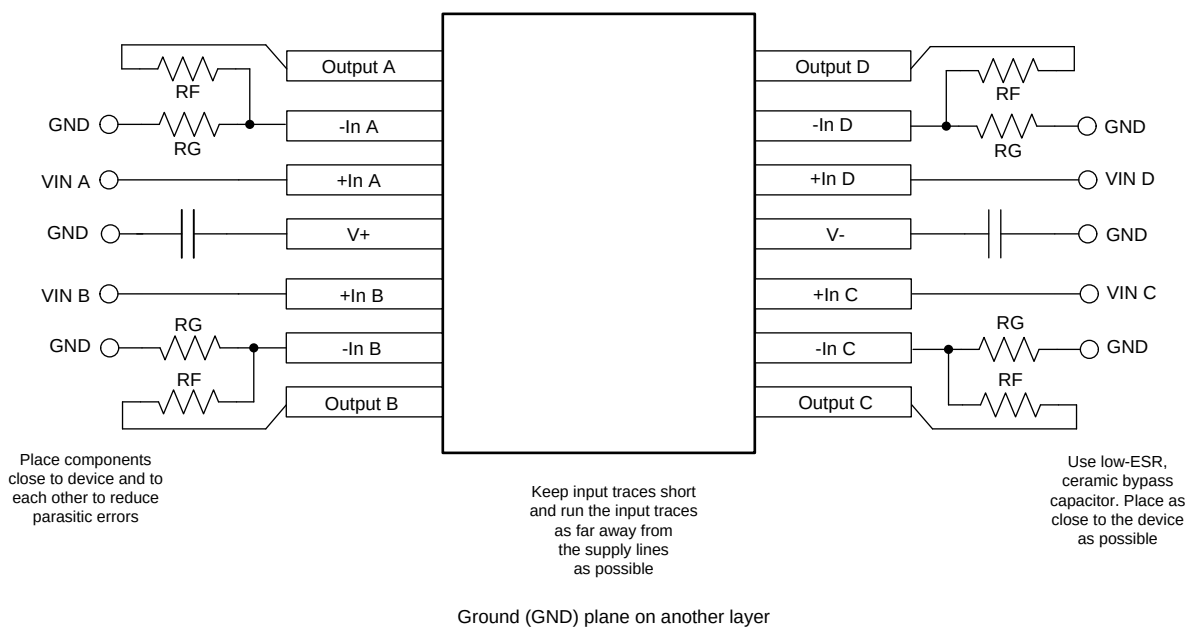
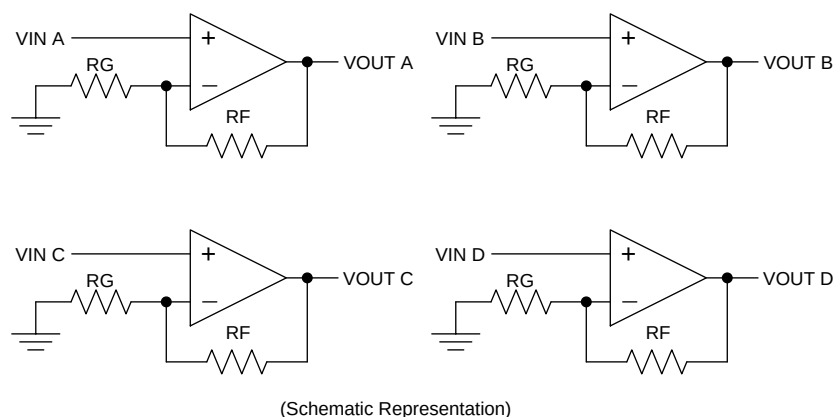


Figure 48. OPA4188 Layout Example

12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Device Support

12.1.1.1 Development Support

12.1.1.1.1 TINA-TI™ (Free Software Download)

TINA™ is a simple, powerful, and easy-to-use circuit simulation program based on a SPICE engine. TINA-TI is a free, fully-functional version of the TINA software, preloaded with a library of macro models in addition to a range of both passive and active models. TINA-TI provides all the conventional DC, transient, and frequency domain analysis of SPICE, as well as additional design capabilities.

Available as a [free download](#) from the Analog eLab Design Center, TINA-TI offers extensive post-processing capability that allows users to format results in a variety of ways. Virtual instruments offer the ability to select input waveforms and probe circuit nodes, voltages, and waveforms, creating a dynamic quick-start tool.

NOTE

These files require that either the TINA software (from DesignSoft™) or TINA-TI software be installed. Download the free TINA-TI software from the [TINA-TI folder](#).

12.1.1.1.2 TI Precision Designs

The OPAx188 devices (or similar operational amplifiers) are featured in several TI Precision Designs, available online at <http://www.ti.com/ww/en/analog/precision-designs/>. TI Precision Designs are analog solutions created by TI's precision analog applications experts and offer the theory of operation, component selection, simulation, complete PCB schematic and layout, bill of materials, and measured performance of many useful circuits.

12.1.1.1.3 WEBENCH® Filter Designer

[WEBENCH® Filter Designer](#) is a simple, powerful, and easy-to-use active filter design program. The WEBENCH® Filter Designer allows the user to create optimized filter designs using a selection of TI operational amplifiers and passive components from TI's vendor partners.

Available as a web based tool from the WEBENCH® Design Center, [WEBENCH® Filter Designer](#) allows the user to design, optimize, and simulate complete multistage active filter solutions within minutes.

12.1.2 Related Documentation

For related documentation see the following:

- [Circuit Board Layout Techniques](#) (SLOA089).
- [Op Amps for Everyone](#) (SLOD006).
- [Operational amplifier gain stability, Part 3: AC gain-error analysis](#) (SLYT383).
- [Operational amplifier gain stability, Part 2: DC gain-error analysis](#) (SLYT374).
- [Using infinite-gain, MFB filter topology in fully differential active filters](#) (SLYT343).
- [Op Amp Performance Analysis](#) (SBOA054).
- [Single-Supply Operation of Operational Amplifiers](#) (SBOA059).
- [, Tuning in Amplifiers](#) (SBOA067).
- [Shelf-Life Evaluation of Lead-Free Component Finishes](#) (SZZA046).

12.2 Trademarks

TINA-TI is a trademark of Texas Instruments, Inc and DesignSoft, Inc.
TINA, DesignSoft are trademarks of DesignSoft, Inc.
All other trademarks are the property of their respective owners.

12.3 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.4 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
OPA4188AID	Active	Production	SOIC (D) 14	50 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AID.B	Active	Production	SOIC (D) 14	50 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AIDG4	Active	Production	SOIC (D) 14	50 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AIDG4.B	Active	Production	SOIC (D) 14	50 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AIDR	Active	Production	SOIC (D) 14	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AIDR.B	Active	Production	SOIC (D) 14	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AIPW	Active	Production	TSSOP (PW) 14	90 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AIPW.B	Active	Production	TSSOP (PW) 14	90 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AIPWG4	Active	Production	TSSOP (PW) 14	90 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AIPWG4.B	Active	Production	TSSOP (PW) 14	90 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AIPWR	Active	Production	TSSOP (PW) 14	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188
OPA4188AIPWR.B	Active	Production	TSSOP (PW) 14	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4188

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

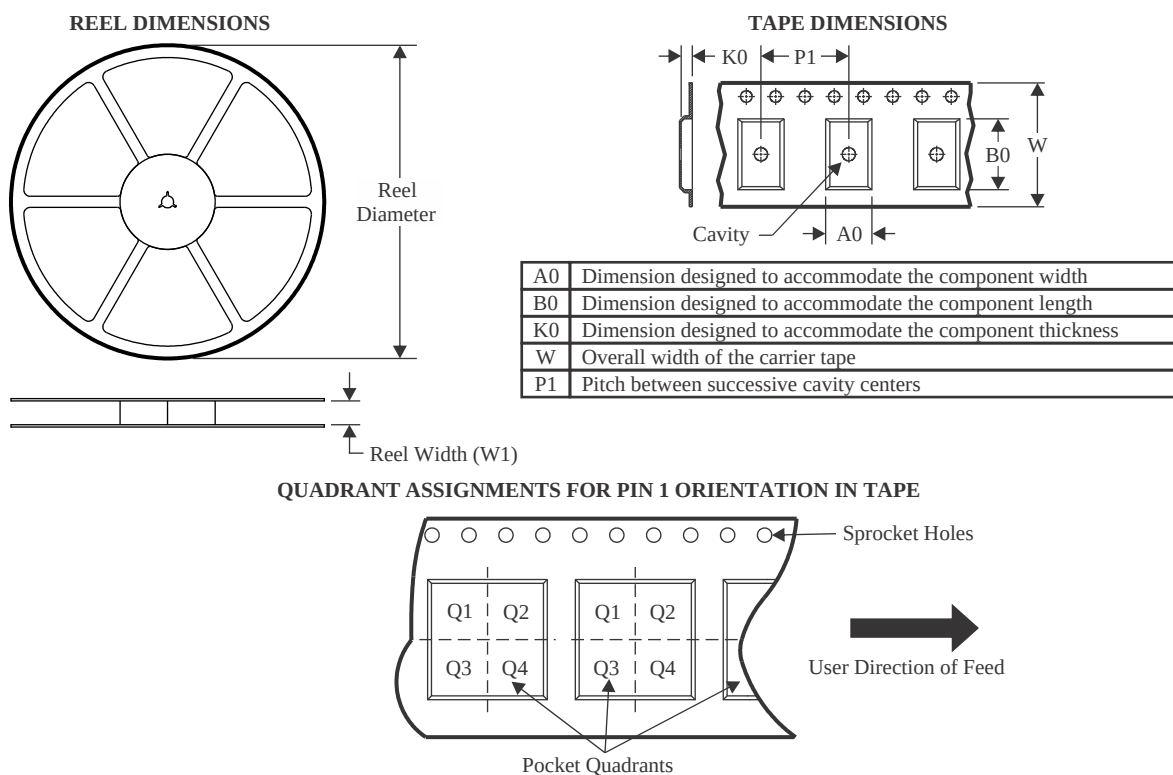
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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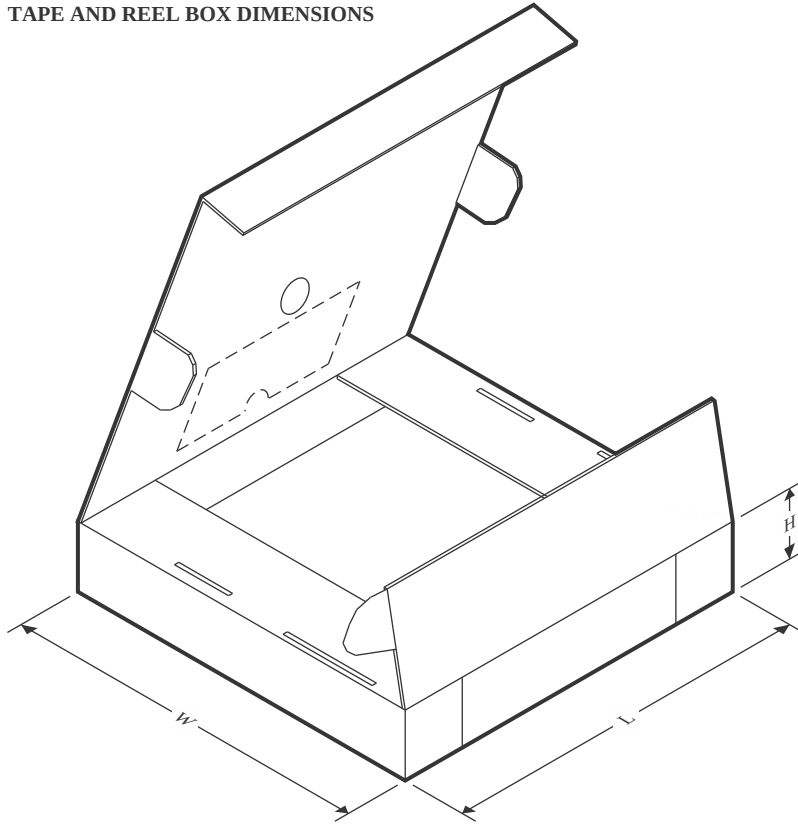
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA4188AIDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
OPA4188AIPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

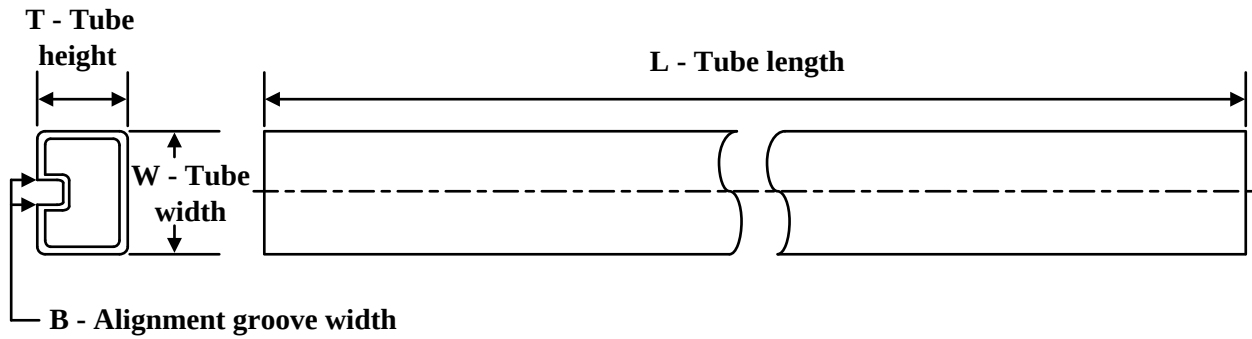
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

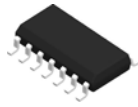
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA4188AIDR	SOIC	D	14	2500	353.0	353.0	32.0
OPA4188AIPWR	TSSOP	PW	14	2000	353.0	353.0	32.0

TUBE

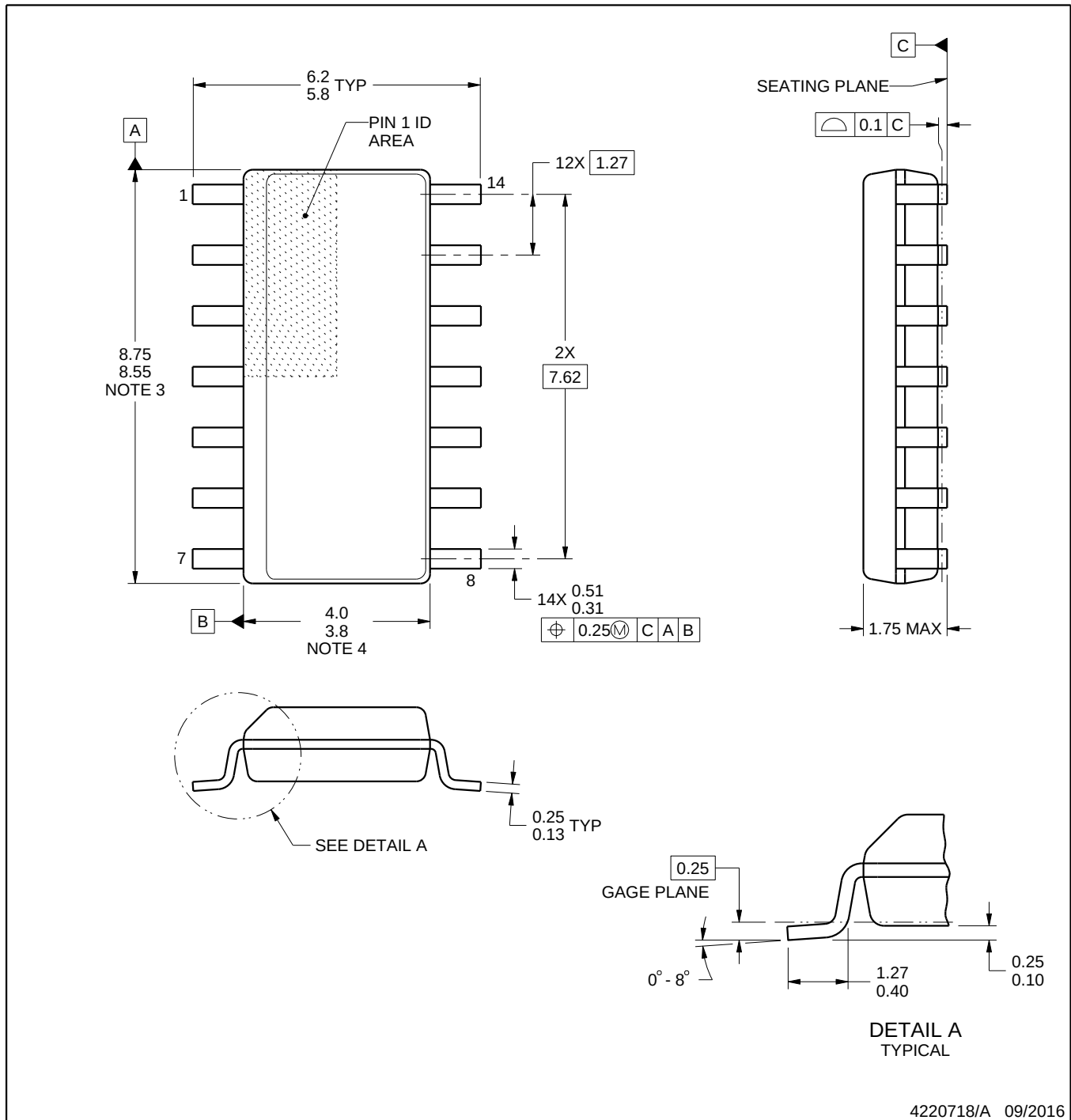


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
OPA4188AID	D	SOIC	14	50	506.6	8	3940	4.32
OPA4188AID.B	D	SOIC	14	50	506.6	8	3940	4.32
OPA4188AIDG4	D	SOIC	14	50	506.6	8	3940	4.32
OPA4188AIDG4.B	D	SOIC	14	50	506.6	8	3940	4.32
OPA4188AIPW	PW	TSSOP	14	90	508	8.5	3250	2.8
OPA4188AIPW.B	PW	TSSOP	14	90	508	8.5	3250	2.8
OPA4188AIPWG4	PW	TSSOP	14	90	508	8.5	3250	2.8
OPA4188AIPWG4.B	PW	TSSOP	14	90	508	8.5	3250	2.8

D0014A**PACKAGE OUTLINE****SOIC - 1.75 mm max height**

SMALL OUTLINE INTEGRATED CIRCUIT

**NOTES:**

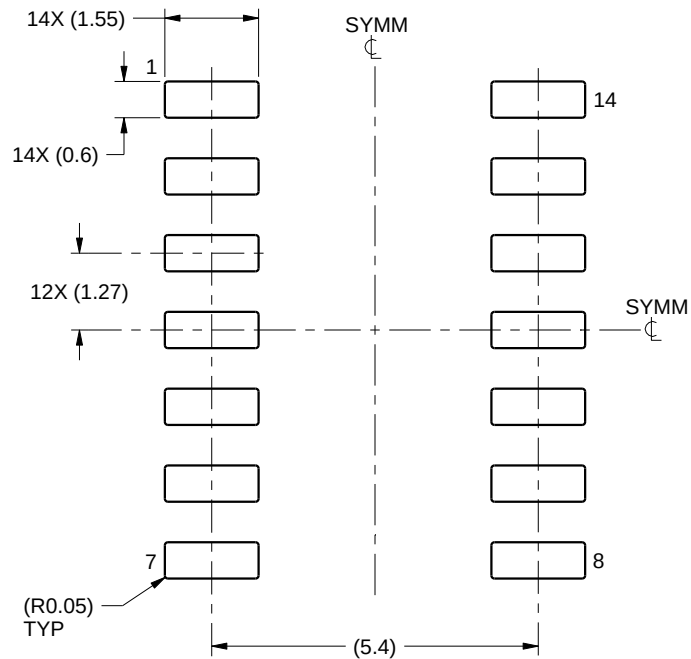
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
5. Reference JEDEC registration MS-012, variation AB.

EXAMPLE BOARD LAYOUT

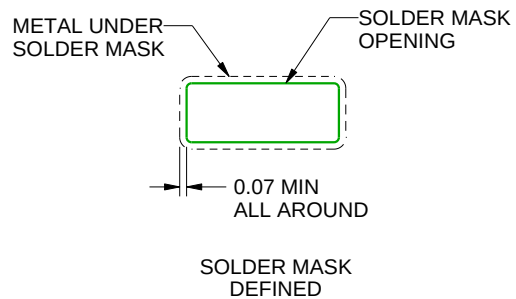
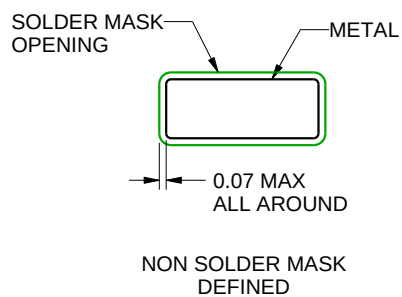
D0014A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
SCALE:8X



SOLDER MASK DETAILS

4220718/A 09/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

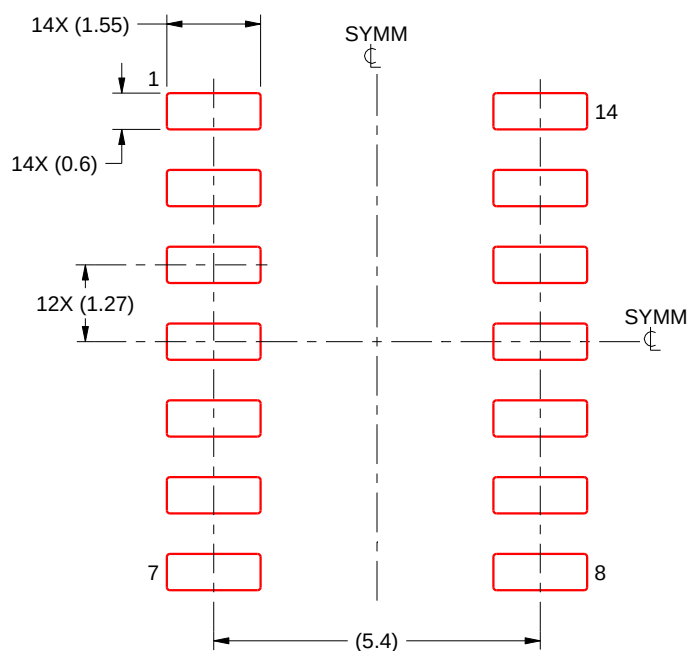
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0014A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:8X

4220718/A 09/2016

NOTES: (continued)

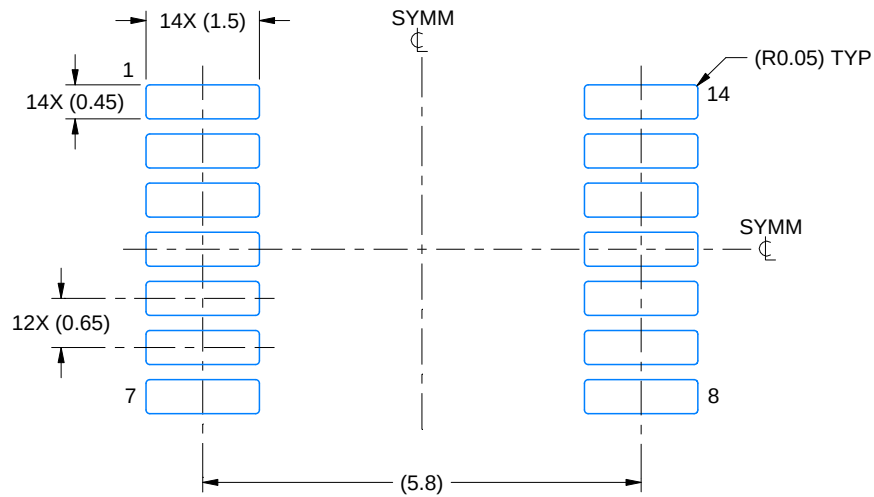
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

EXAMPLE BOARD LAYOUT

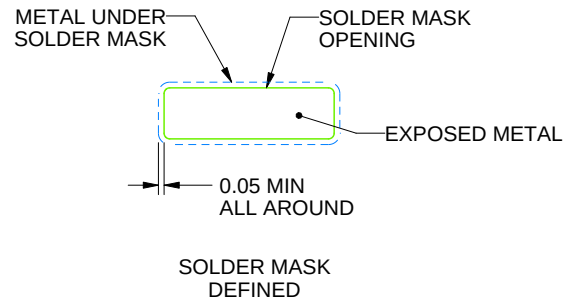
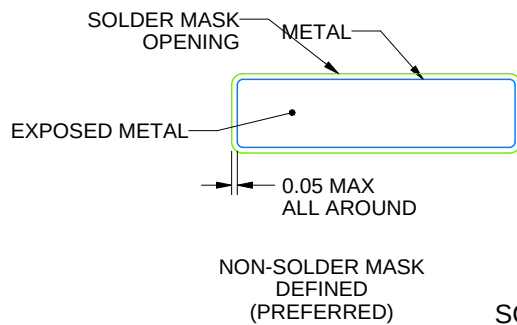
PW0014A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



SOLDER MASK DETAILS

4220202/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

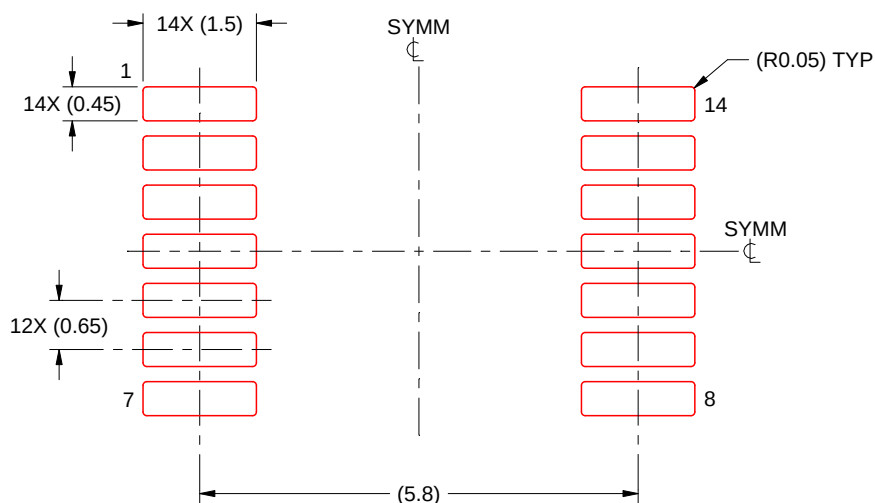
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0014A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220202/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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